



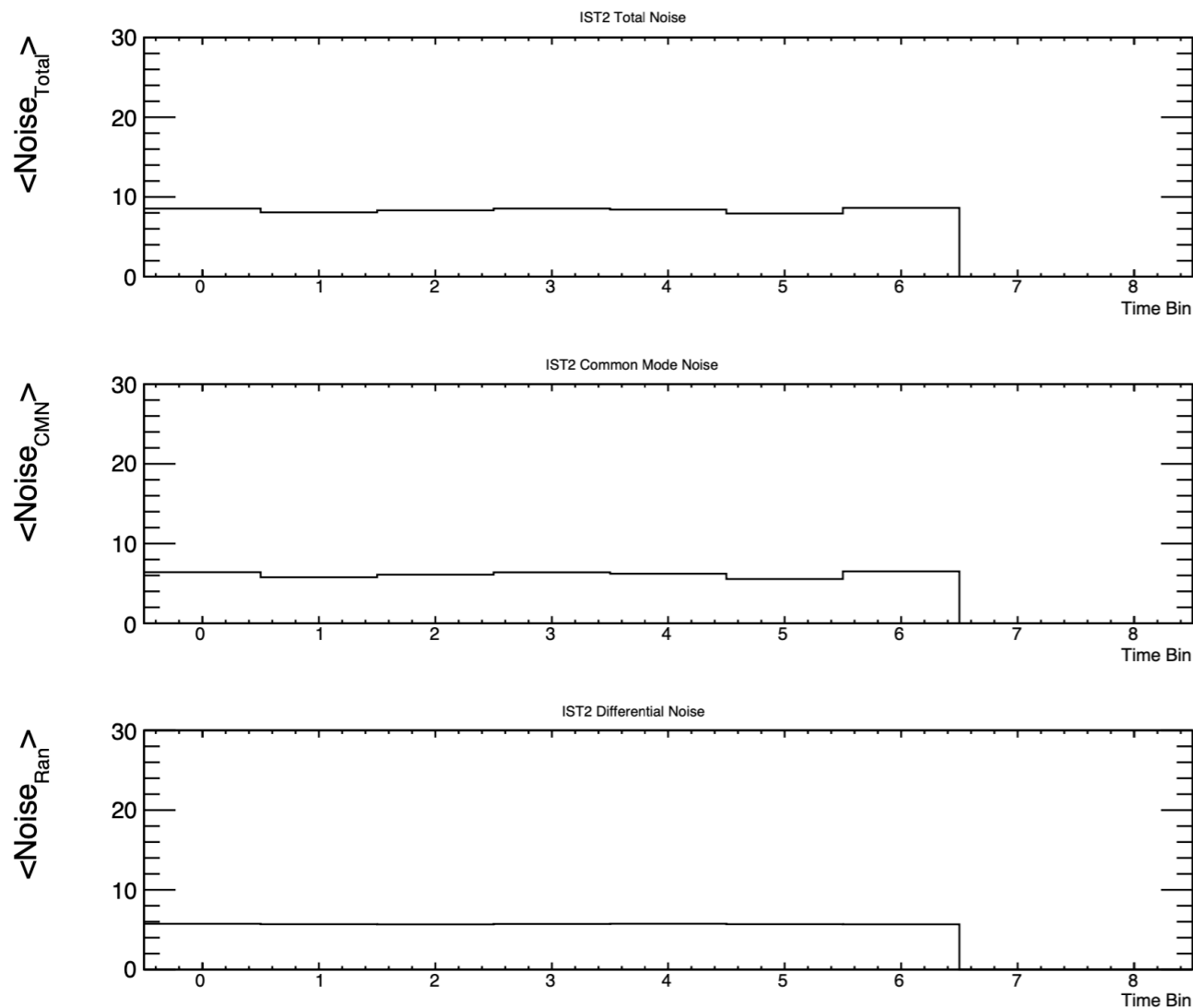
# Noise of IST & FST

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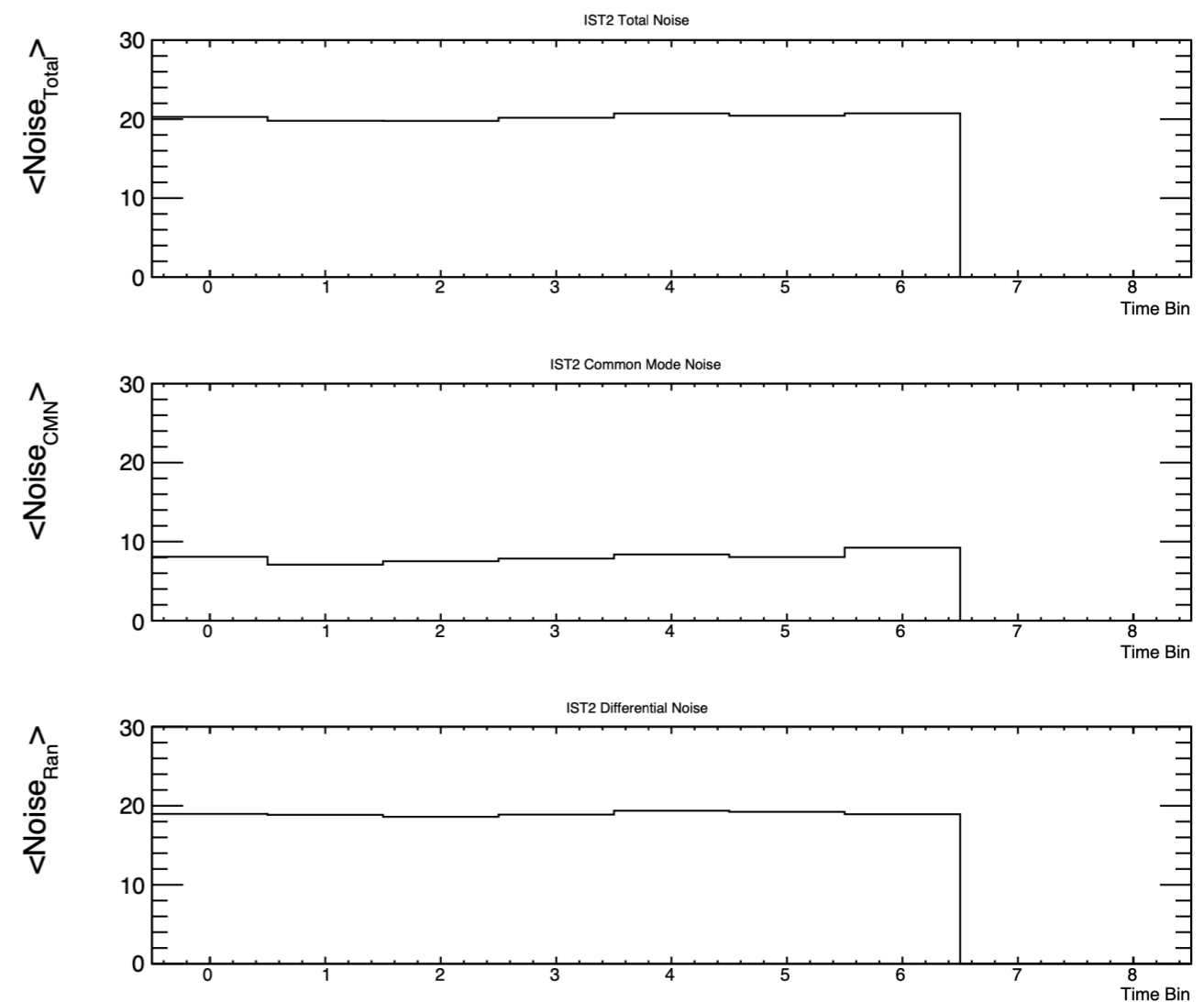
# IST 27 Noise from 2013



## Chip Only



## With Sensor



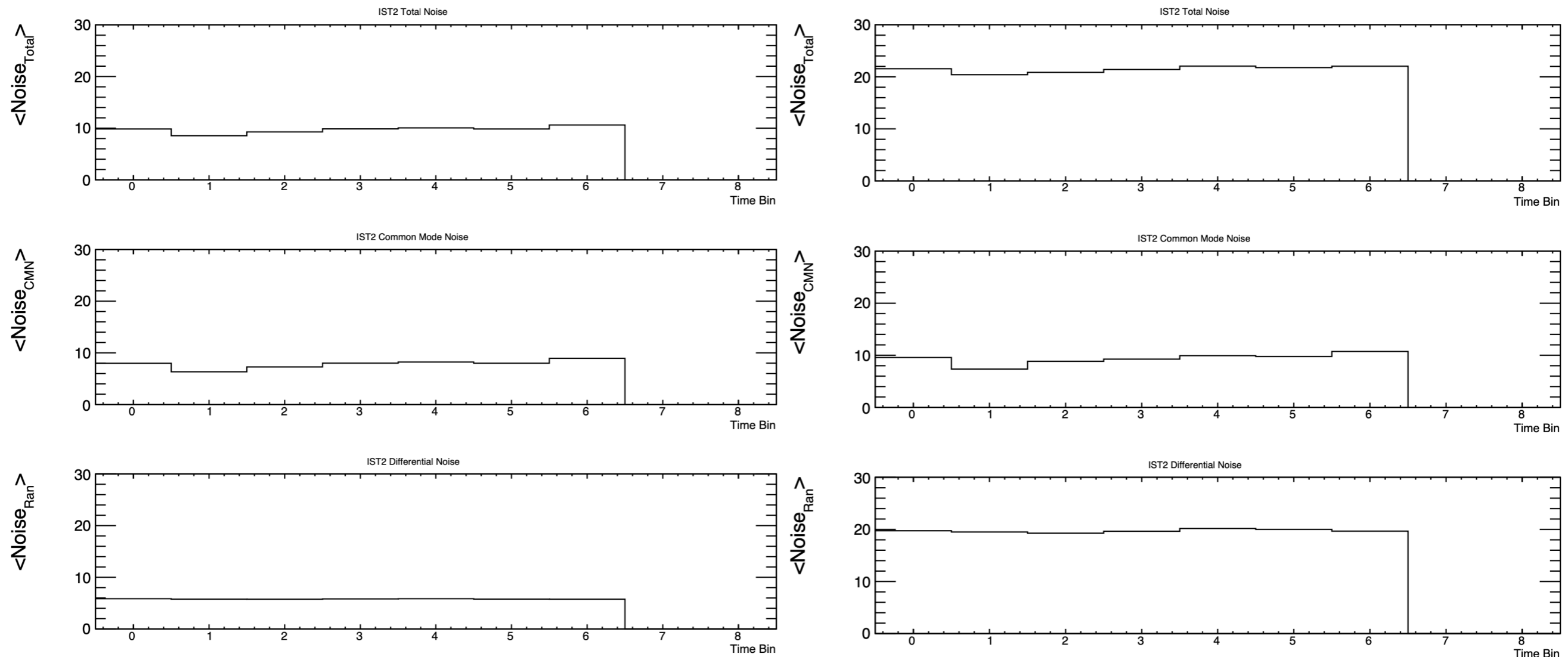
- Total & random noise increased significantly after sensor mounting.
- CMN is less affected by the sensor mounting.

# IST 36 Noise from 2013



## Chip Only

## With Sensor



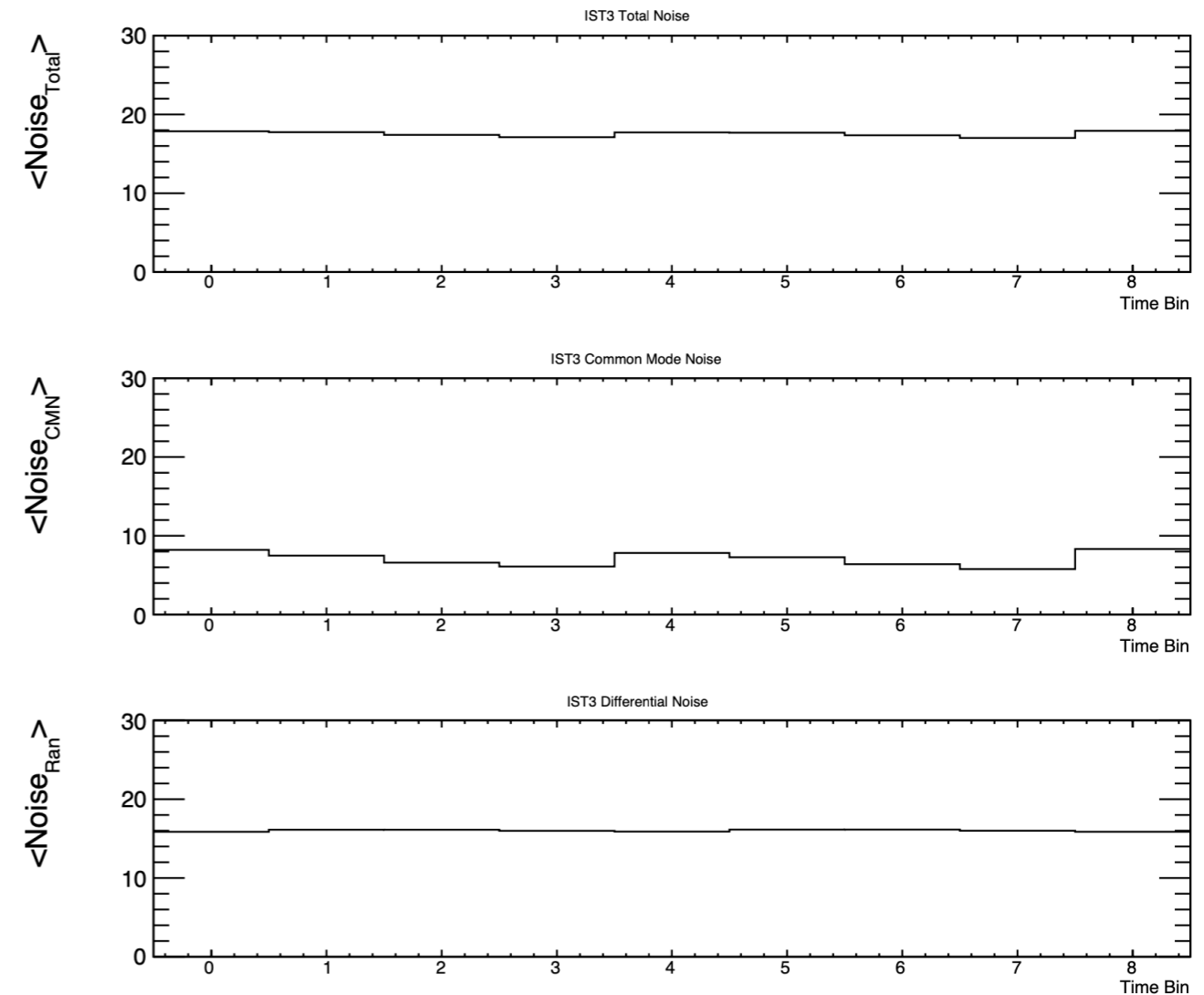
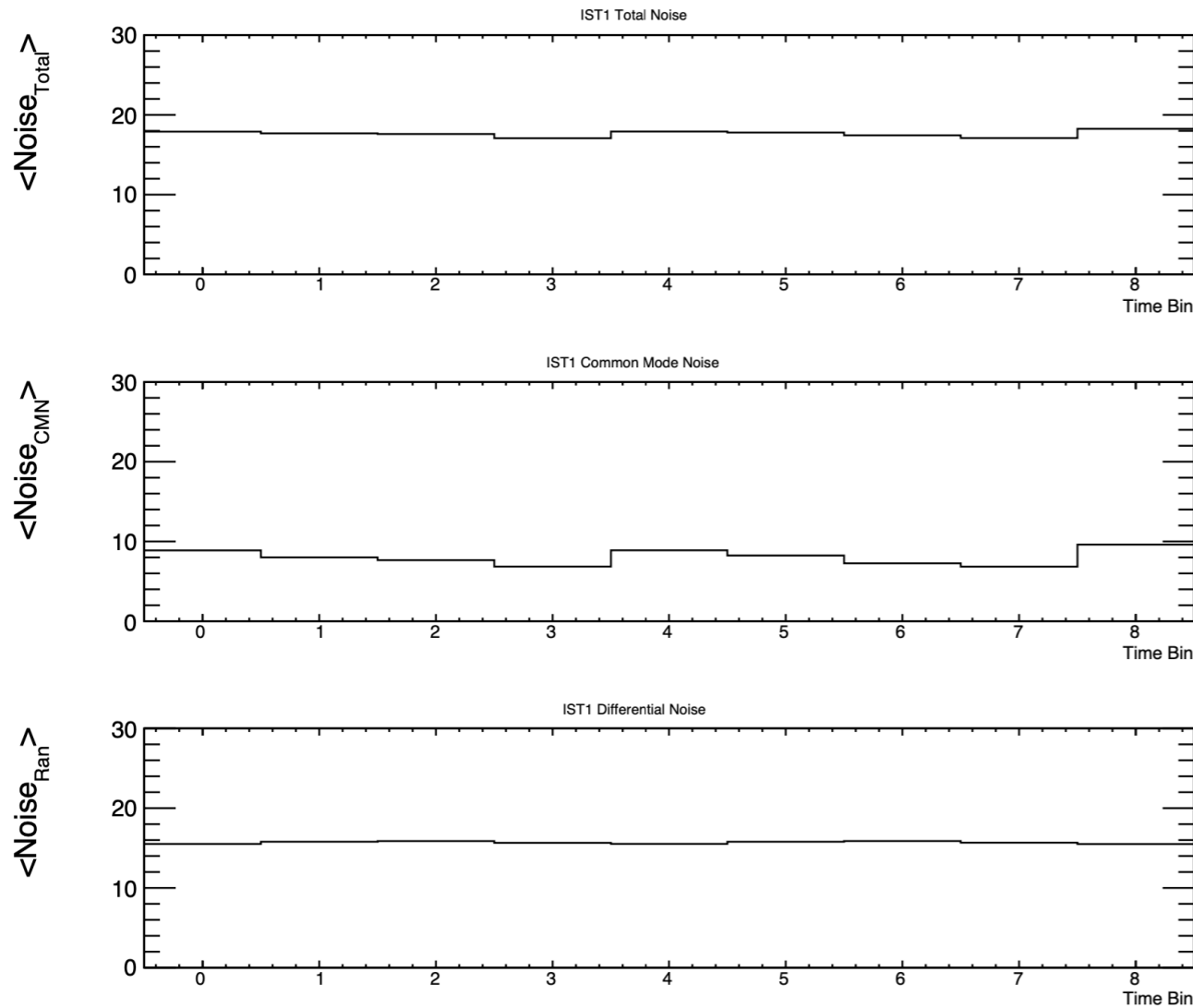
- Total & random noise increased significantly after sensor mounting.
- CMN is less affected by the sensor mounting.
- The noise patten is the same as IST27.

# IST Noise in Current Test Stand



## Top IST With Sensor

## Bottom IST With Sensor

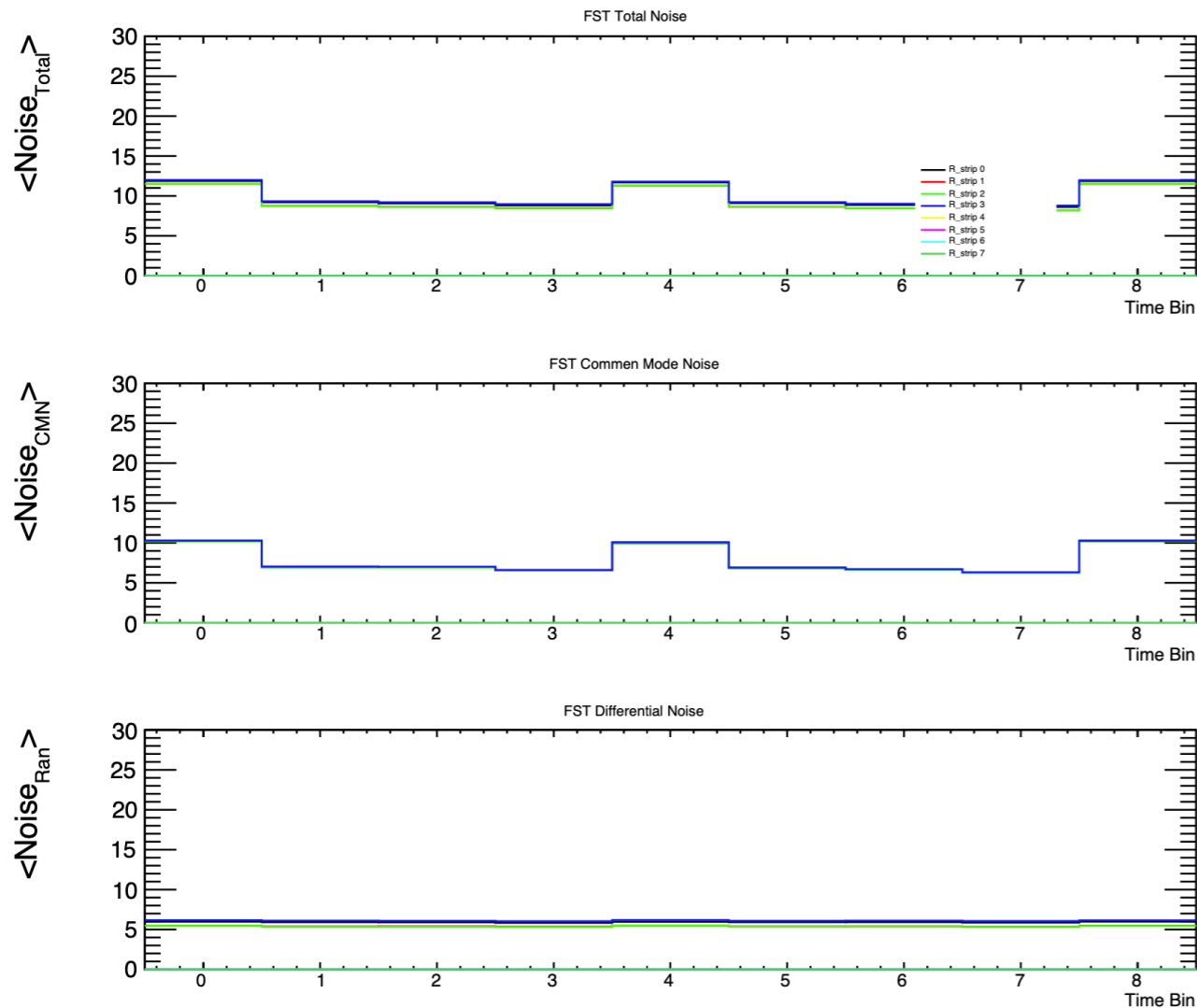


- Noise of IST in the current test stand behaves similarly to the IST from 2013 production.

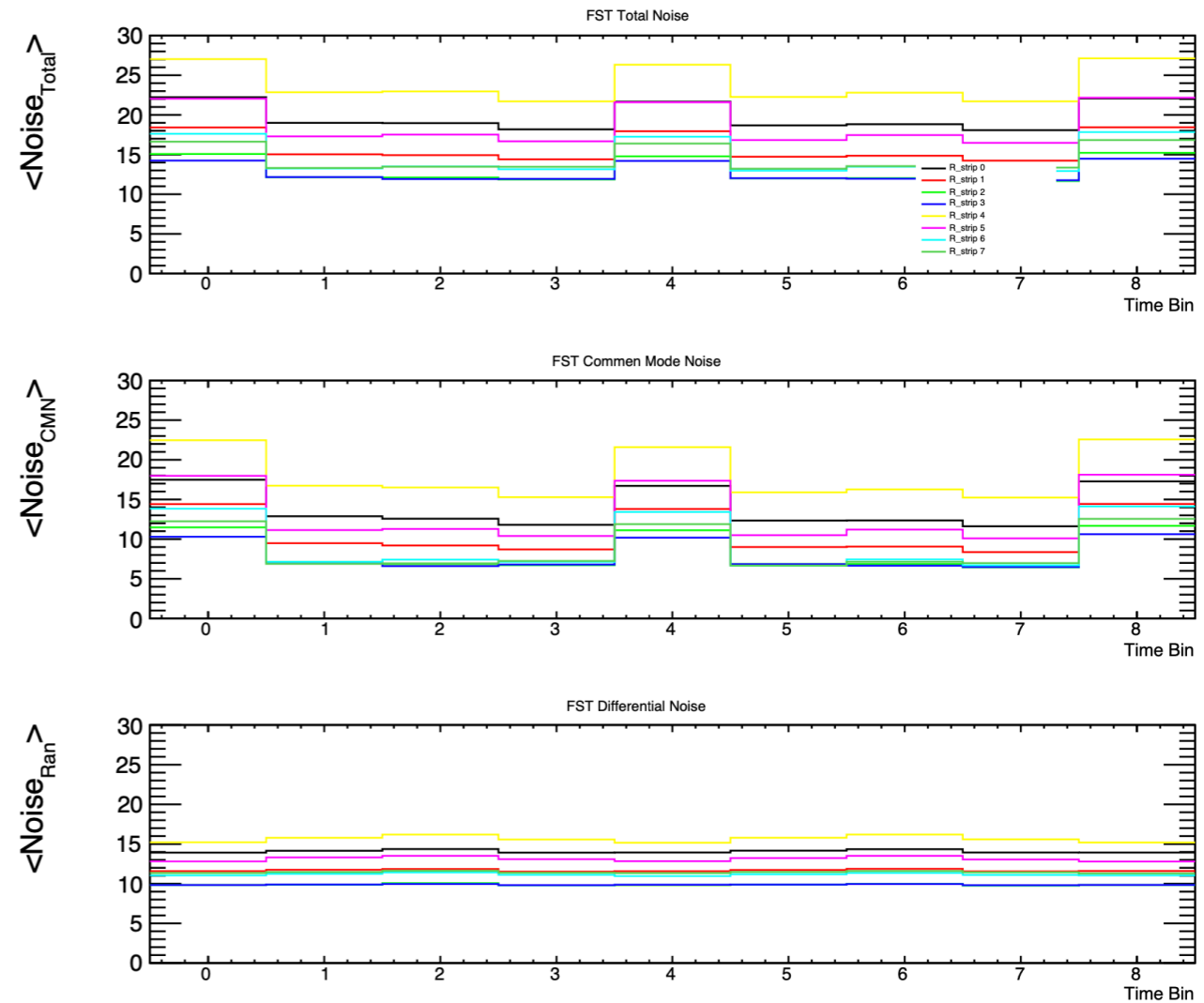
# FST 04 Noise



## Chip Only



## With Sensor



- Total & random noise increased significantly after sensor mounting.
- CMN also increased significantly after sensor mounting.
- CMN of FST behaves differently from CMN of IST indicates the large CMN in FST may not come from larger capacitance.